

Description

The HSI4925DDYT1GE3 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

 $V_{DS} = -30V, I_{D} = -8.5A$

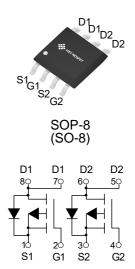
 $R_{DS(ON)}$ < 18m @ V GS=-10V

 $R_{DS(ON)} < 28m @ V_{GS}=-4.5V$

Application

PWM application

Load switch



Dual P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
HSI4925DDYT1GE3	SOP-8(SO-8)	HXY MOSFET	3000

Absolute Maximum Ratings (T_A=25 ^oC unless otherwise noted)

Symbol	Parameter	Limit	Unit
V _D s	Drain-Source Voltage	-30	V
Vgs	Gate-Source Voltage	±20	V
I _D	Drain Current-Continuous	-8.5	Α
Ірм	Drain Current-Pulsed (Note 1)	-26	Α
P _D	Maximum Power Dissipation	1.5	W
T _J ,T _{STG}	Operating Junction and Storage Temperature Range	-55 To 150	$^{\circ}$ C
Reja	Thermal Resistance,Junction-to-Ambient (Note 2)	85	°C/W



Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_D =-250 u A	-30			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.022		V/°C
D	·Static Drain-Source On-Resistance²	V _{GS} =-10V , I _D =-6A	14 18		18	
R _{DS(ON)}		V _{GS} =-4.5V , I _D =-4A		22	28	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} . In =-250uA	-1.0		-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID250UA		4.6		mV/°C
	Dunin Course Looke as Courset	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			-1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =55°C			-5	
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-6A		17		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		13		Ω
Qg	Total Gate Charge (-4.5V)			12.6		
Q _{gs}	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-6A		4.8		nC
Q _{gd}	Gate-Drain Charge			4.8		
T _{d(on)}	Turn-On Delay Time			4.6		
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_G =3.3 Ω ,		14.8		20
T _{d(off)}	Turn-Off Delay Time	I _D =-6A		41		ns
Tf	Fall Time			19.6		
Ciss	Input Capacitance			1345		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		194		pF
Crss	Reverse Transfer Capacitance			158		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,5}	\/ -\/ -0\/ Faras Current			-6.5	Α
I _{SM}	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			-26	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V
t _{rr}	Reverse Recovery Time			16.3		nS
Qrr	Reverse Recovery Charge	lF=-6A,dl/dt=100A/µs,Tյ=25°C		5.9		nC

Note

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-38A
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



Typical Characteristics

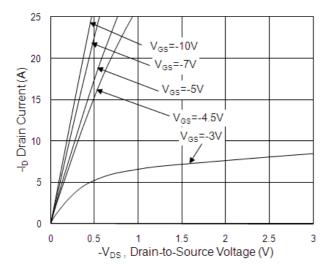


Fig.1 Typical Output Characteristics

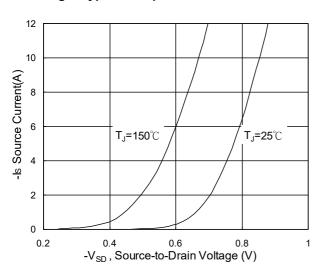


Fig.3 Forward Characteristics of Reverse

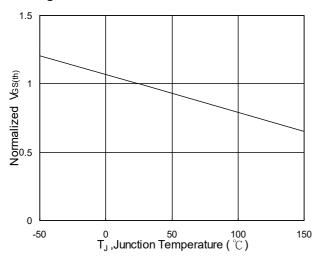


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

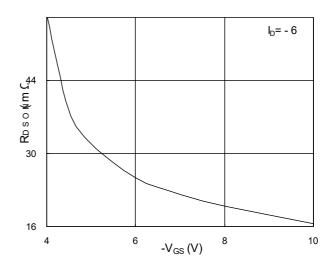


Fig.2 On-Resistance v.s Gate-Source

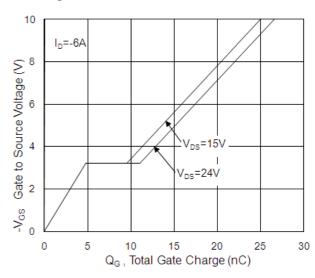


Fig.4 Gate-Charge Characteristics

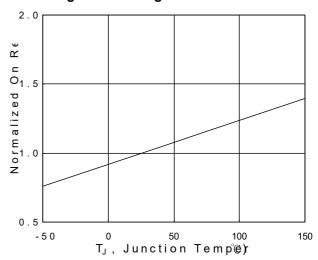
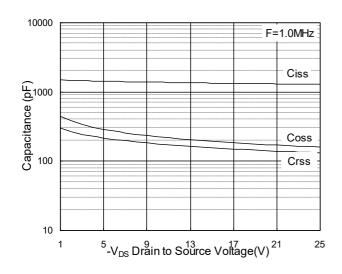


Fig.6 Normalized R_{DSON} vs. T_J



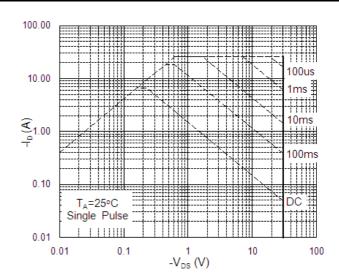


Fig.7 Capacitance

Fig.8 Safe Operating Area

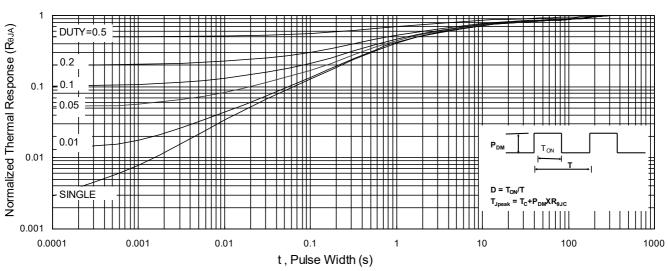
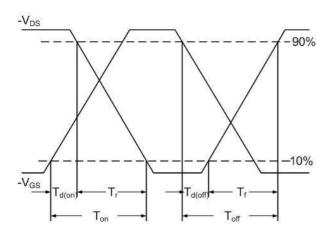
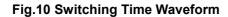


Fig.9 Normalized Maximum Transient Thermal Impedance





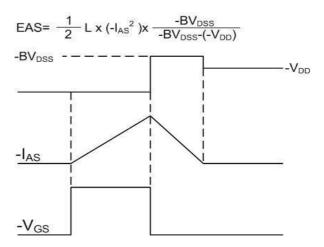
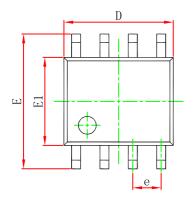
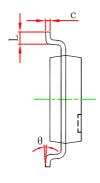


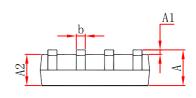
Fig.11 Unclamped Inductive Switching Waveform



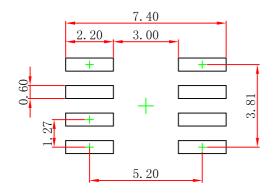
SOP-8(SO-8)Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
Α	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
С	0.170	0.250	0.007	0.010
D	4.800	5.000	0.189	0.197
е	1.270 ((BSC)	0.050	(BSC)
E	5.800	6.200	0.228	0.244
E1	3.800	4.000	0.150	0.157
Ĺ	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°



- Note: 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

Dual P-Channel Enhancement Mode MOSFET

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